



天津大学
Tianjin University



Virtual Scanning

Unsupervised Non-line-of-sight Imaging from Irregularly Undersampled Transients

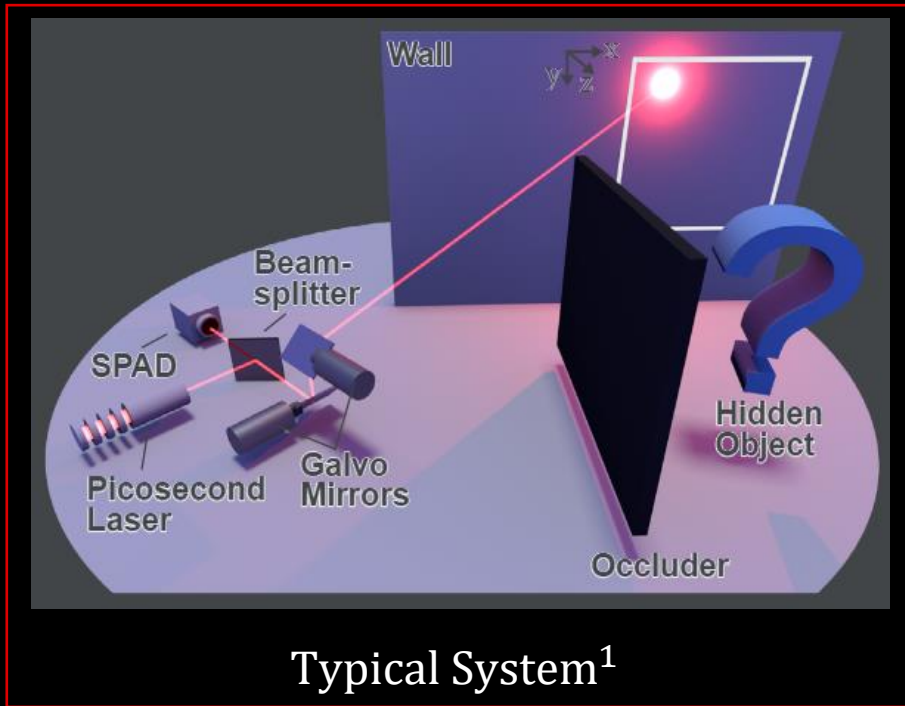
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Yusen Hou¹ YunMeng^{2,3} KaiZou^{2,3} Xiaolong Hu^{2,3} Jingyu Yang^{1,*}

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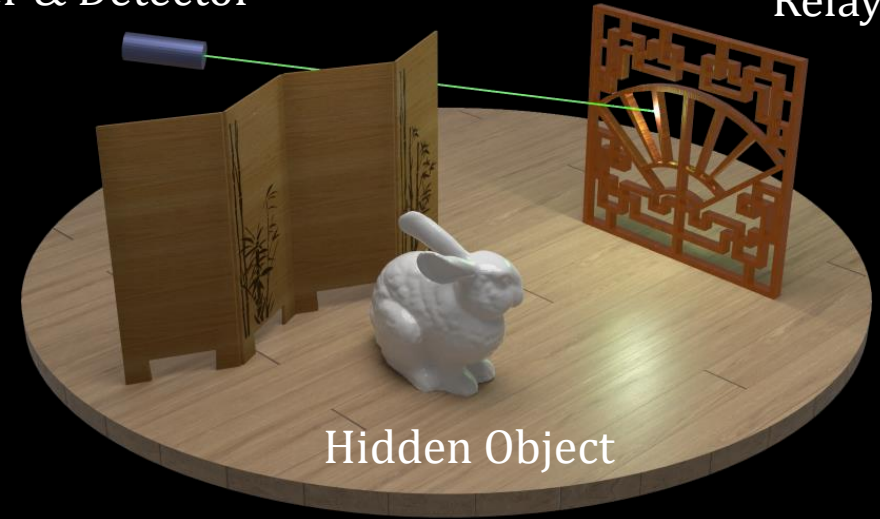
Non-line-of-sight Imaging (NLOS imaging)



Laser & Detector

Relay Surface

Limited relay surface

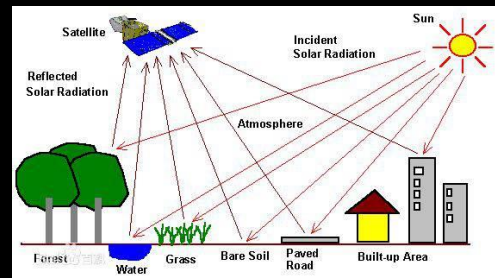


Hidden Object

Challenge Task



Rescue Operations



Remote Sensing



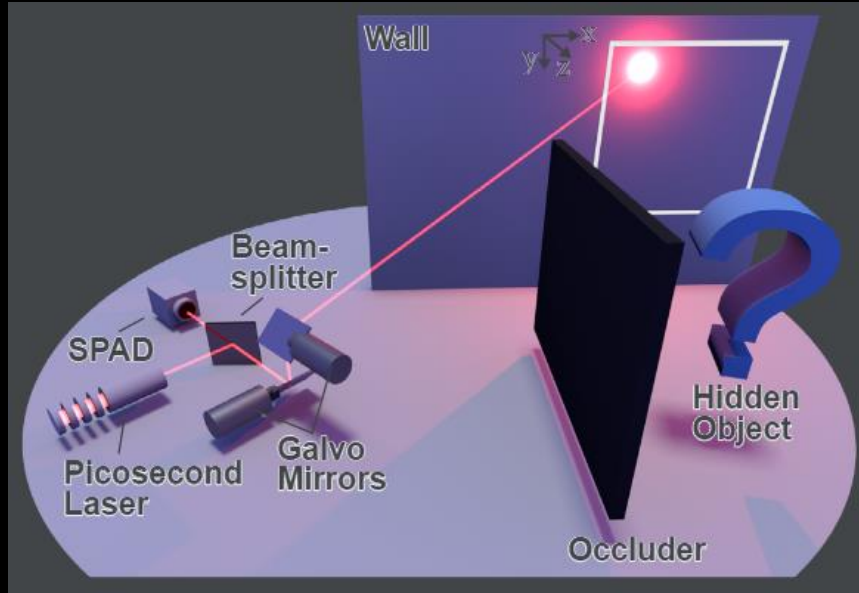
Autonomous Driving



Medical Imaging

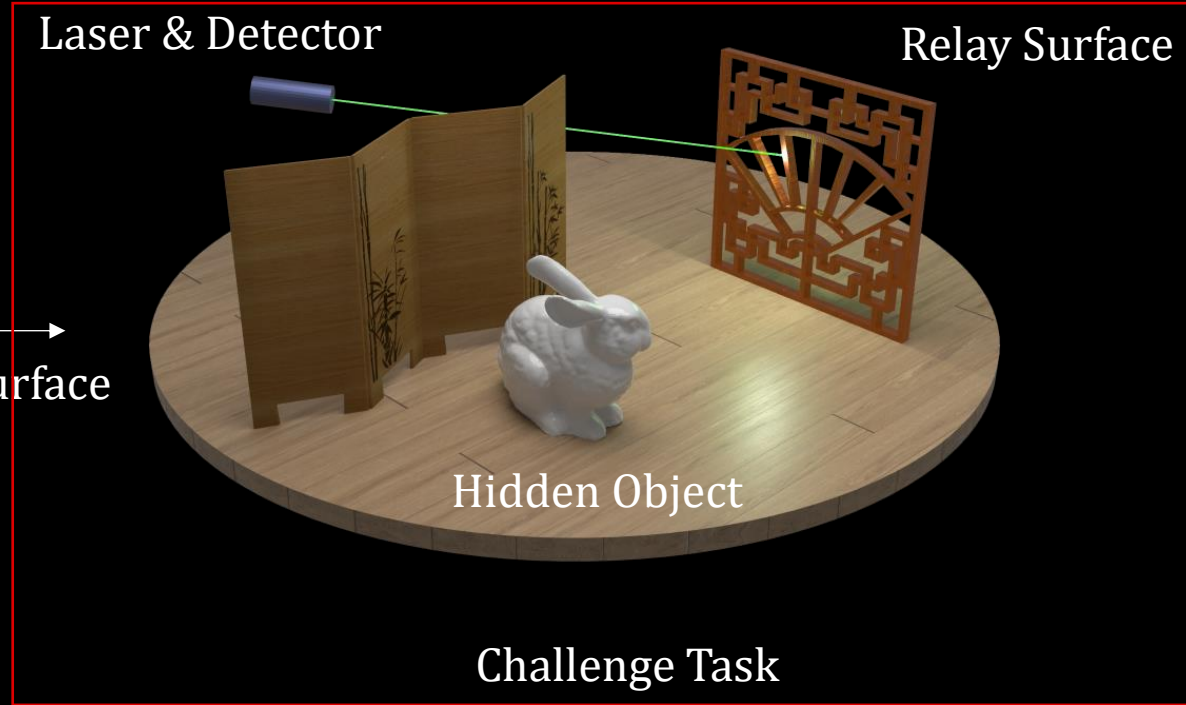
¹Wave-Based Non-Line-of-Sight Imaging using Fast $f-k$ Migration

Non-line-of-sight Imaging (NLOS imaging)



Typical System¹

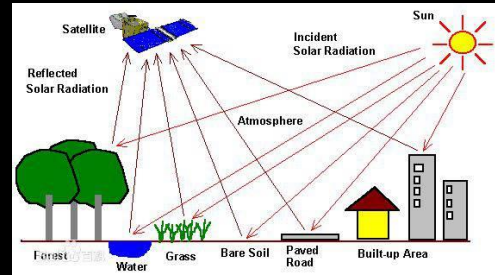
Limited relay surface



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¹Wave-Based Non-Line-of-Sight Imaging using Fast $f-k$ Migration

Non-line-of-sight Imaging from Irregularly Undersampled Transient



Nonlinear Forward Model

$$\tau(p, t) = \int_Q \frac{\kappa(q)}{\|p - q\|^4} \cdot \delta(2\|p - q\| - tc) dq$$

Model Simplification

Linear Forward Model

$$u = H\rho$$

Non-line-of-sight Imaging from Irregularly Undersampled Transient



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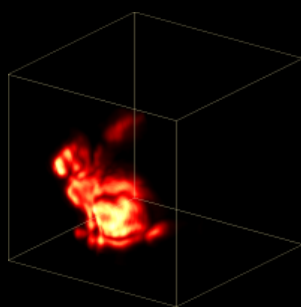
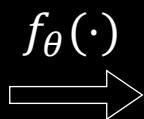
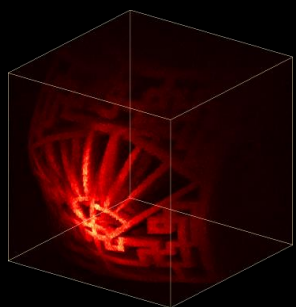
Motivation

To solve the challenge inverse problem:

$$\rho = \arg \min_{\rho} \|u - H\rho\|_2^2$$

Supervised Learning

$$\mathbb{E}_u \|f_{\theta}(u) - \rho_{gt}\|_2^2$$



IUT

Estimated
3D Albedo Volume



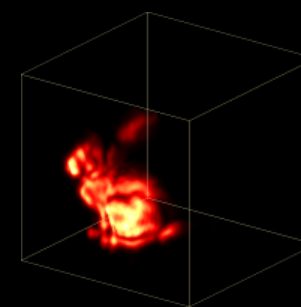
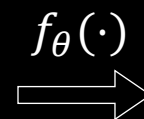
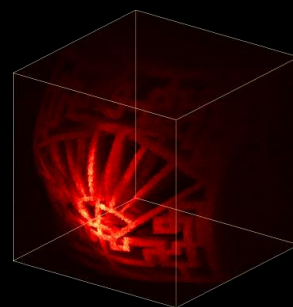
Intensity Map
(Ground Truth)



Depth Map
(Ground Truth)

Unsupervised Learning

$$\mathbb{E}_u \|Hf_{\theta}(u) - u\|_2^2$$



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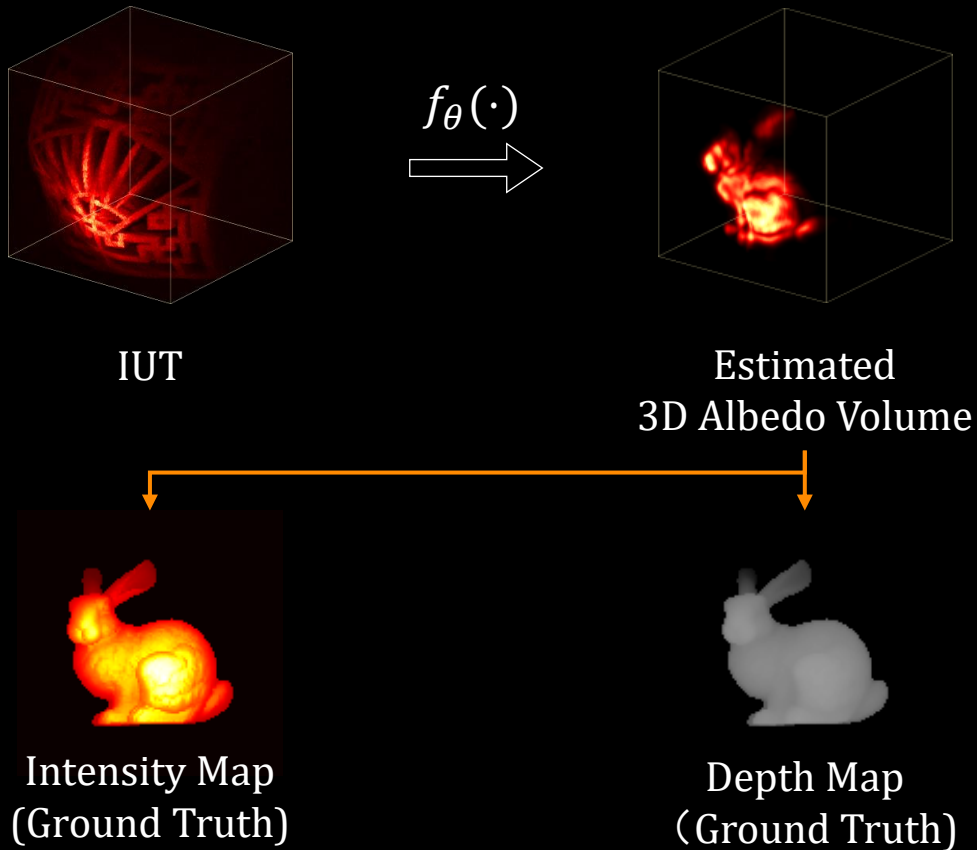
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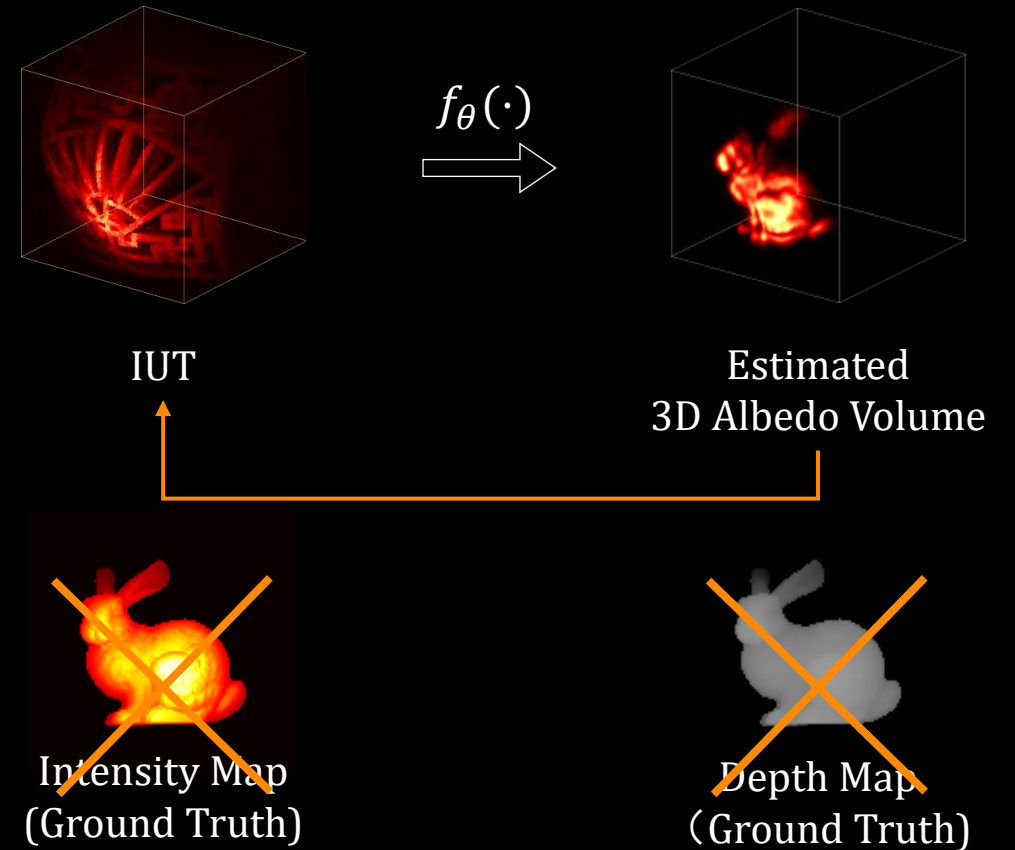
Supervised Learning

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Unsupervised Learning

$$\mathbb{E}_u \|Hf_{\theta}(u) - u\|_2^2$$

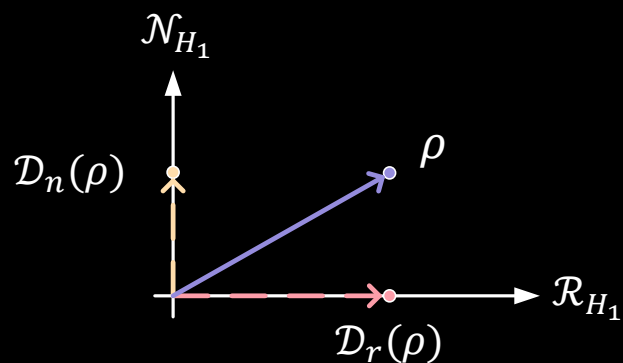


Motivation

Measurement Consistency (MC) is not enough for unsupervised learning.

$$\mathbb{E}_u \|Hf_\theta(u) - u\|_2^2$$

Range-Null Space Decomposition



$$\rho = \underbrace{H^\dagger H \rho}_{\text{range-space component}} + \underbrace{(I - H^\dagger H) \rho}_{\text{null-space component}}$$

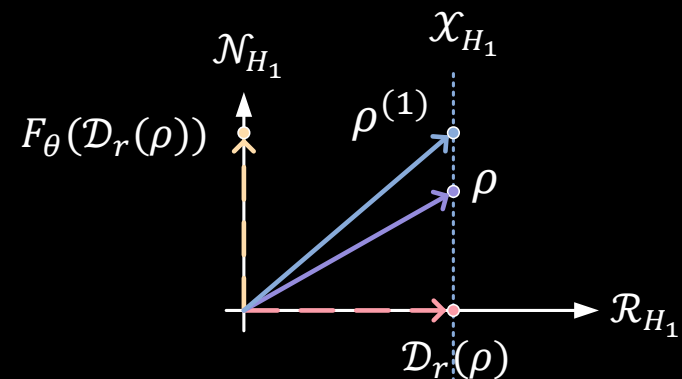
$$\mathcal{R}_H : \mathcal{D}_r(\rho) = H^\dagger H \rho$$

$$\mathcal{R}_H = \{H^\top u, u \in \mathbb{R}^{st}\}$$

$$\mathcal{N}_H : \mathcal{D}_n(\rho) = (I - H^\dagger H) \rho$$

$$\mathcal{N}_H = \{v \in \mathbb{R}^{l^2z} \mid Hv = 0\}$$

Unsupervised learning with MC Loss



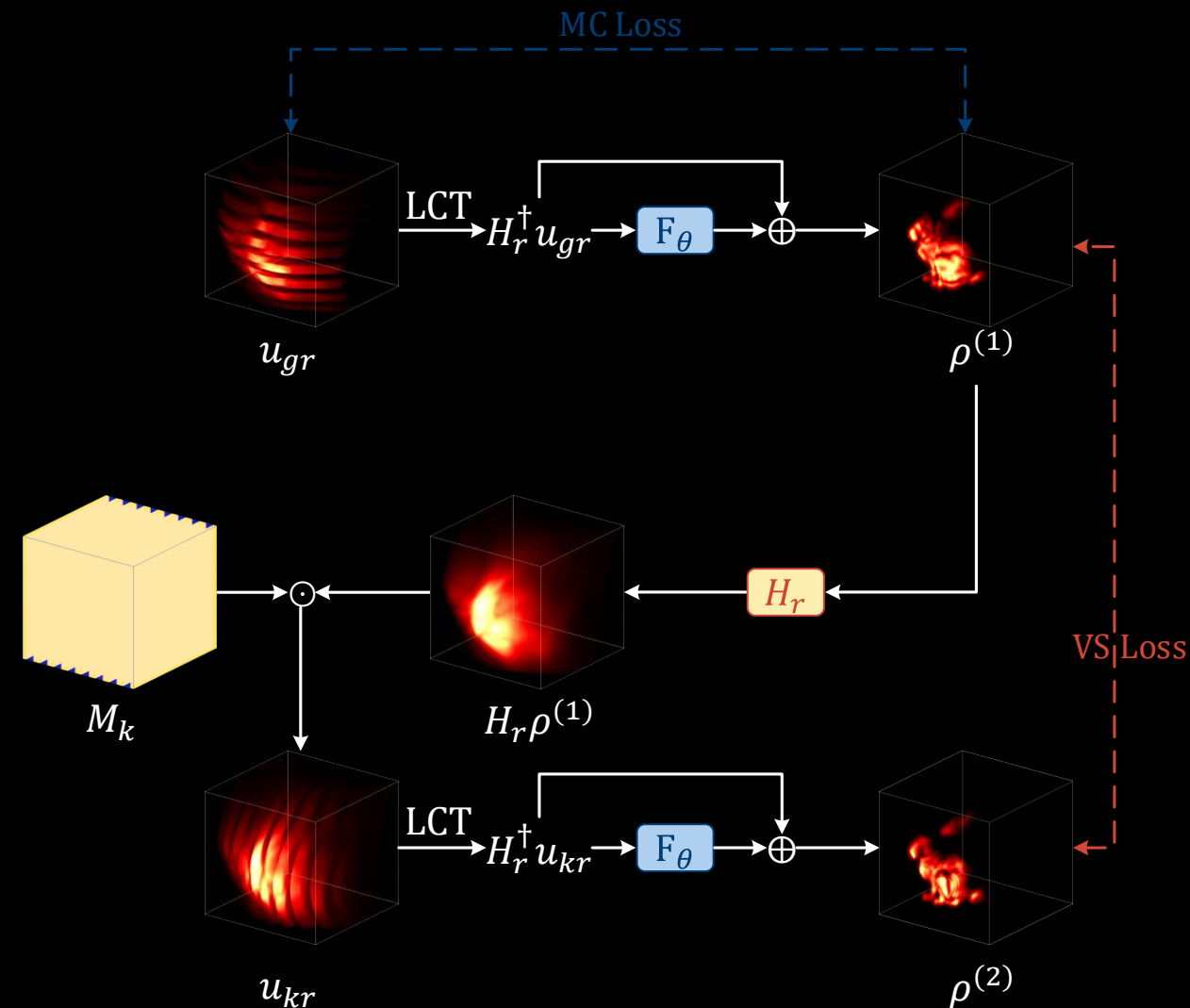
$$\mathcal{X}_{H_1} = \{v \mid H_1^\dagger H_1 v = \mathcal{D}_r(\rho), \mathcal{D}_r(\rho) \in \mathcal{R}_{H_1}\}$$

$$\rho^{(1)} = f_\theta(u) = \mathcal{D}_r(\rho) + F_\theta(\mathcal{D}_r(\rho)) = \mathcal{D}_r(\rho) + v_n, \forall v_n \in \mathcal{N}_H$$

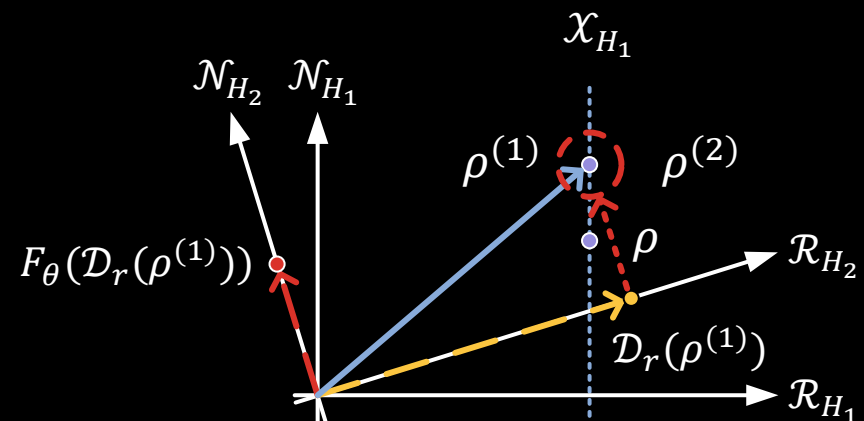
$$H(\mathcal{D}_r(\rho) + v_n) = HH^\dagger H \rho + H v_n = u$$

Virtual Scanning: learn to recover null-space component

Virtual Scanning Process



Recover Null-space Component



$$\rho^{(1)} = f_\theta(u_{gr}) = H_r^\dagger u_{gr} + F_\theta(H_r^\dagger u_{gr})$$

$$\rho^{(2)} = f_\theta(H_r \rho^{(1)} \odot M_k)$$

VS Loss

$$\rho^{(2)} \rightarrow \rho^{(1)}$$

Equal to

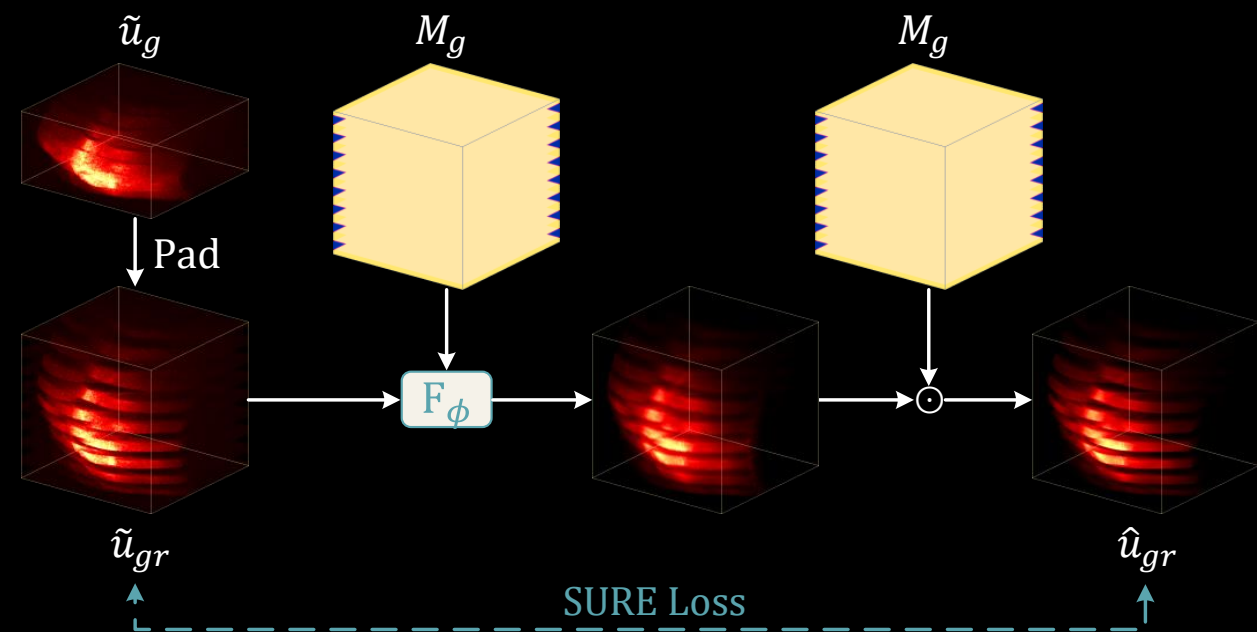
$$F_\theta(\mathcal{D}_r(\rho^{(1)})) + \mathcal{D}_r(\rho^{(1)}) \rightarrow \mathcal{D}_n(\rho^{(1)}) + \mathcal{D}_r(\rho^{(1)})$$

$$F_\theta(\mathcal{D}_r(\rho^{(1)})) \rightarrow \mathcal{D}_n(\rho^{(1)})$$

SURE-based Denoiser

The noise model of NLOS imaging

$$\tilde{u} \sim \text{Poisson}(u + b)$$



- Our SURE-denoiser considers the physical detector model of NLOS, which works in a low-photon condition.
- The denoiser can be also trained without paired data.

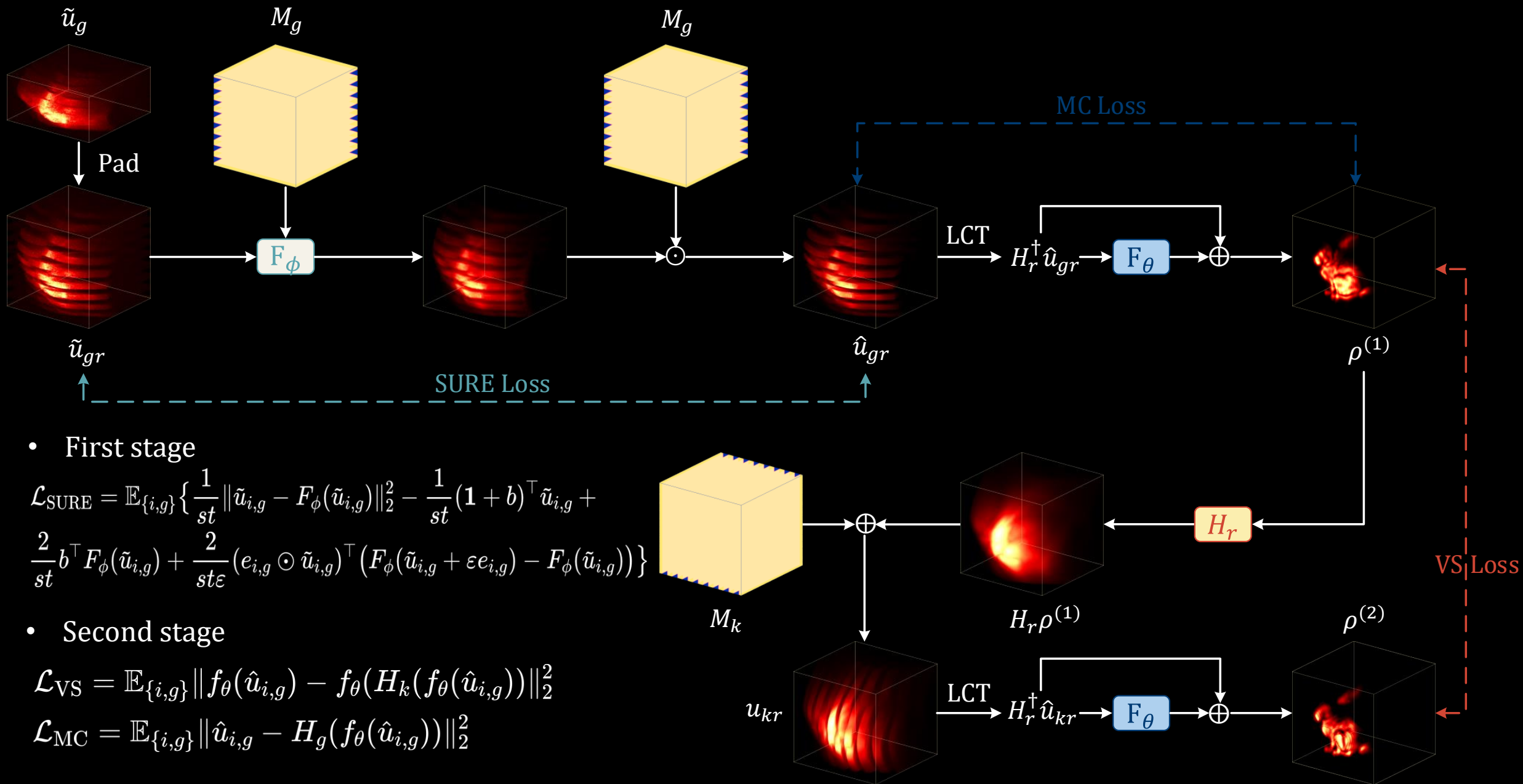
Stein's Unbiased Risk Estimation (SURE) framework can derive **the unbiased estimator of supervised loss function**

$$\mathbb{E}_{\{\tilde{u}, u\}} \left\{ \sum_{j=1}^J \frac{1}{st} \|u_j - F_\phi(\tilde{u}_j)\|^2 \right\} = \mathbb{E}_u \left\{ \sum_{j=1}^J \frac{1}{st} \mathbb{E}_{\tilde{u}|u} \|u_j - F_\phi(\tilde{u}_j)\|^2 \right\}$$

The unsupervised learning SURE-based loss function

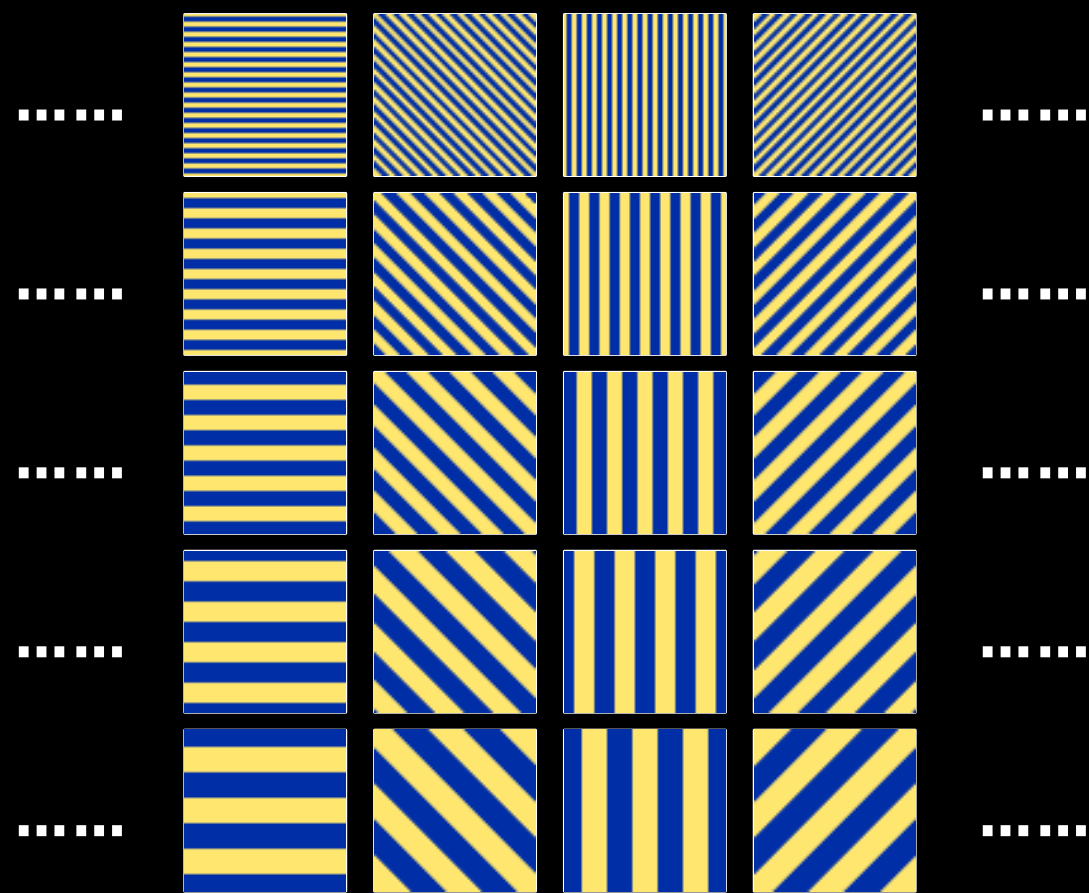
$$\sum_{j=1}^J \frac{1}{st} \left\{ \|\tilde{u}_j - F_\phi(\tilde{u}_j)\|^2 - (\mathbf{1} + b)^\top \tilde{u}_j + 2b^\top F_\phi(\tilde{u}_j) + \frac{2}{\varepsilon} (e_j \odot \tilde{u}_j)^\top (F_\phi(\tilde{u}_j + \varepsilon e_j) - F_\phi(\tilde{u}_j)) \right\}$$

Training Details

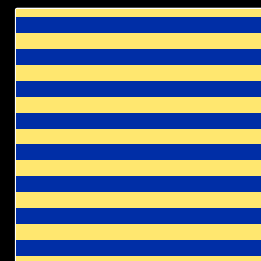


Experiment Setup

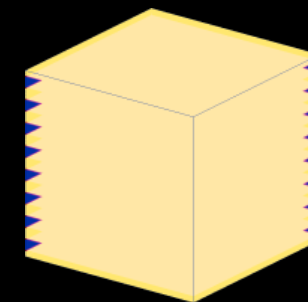
- How to create a group of forward operators



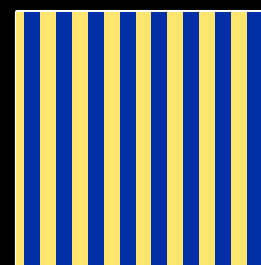
2D Relay Surface



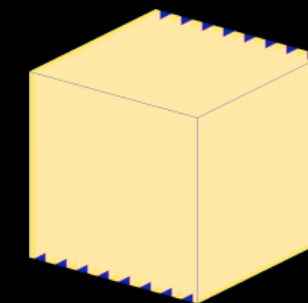
M_g



M_g



M_k

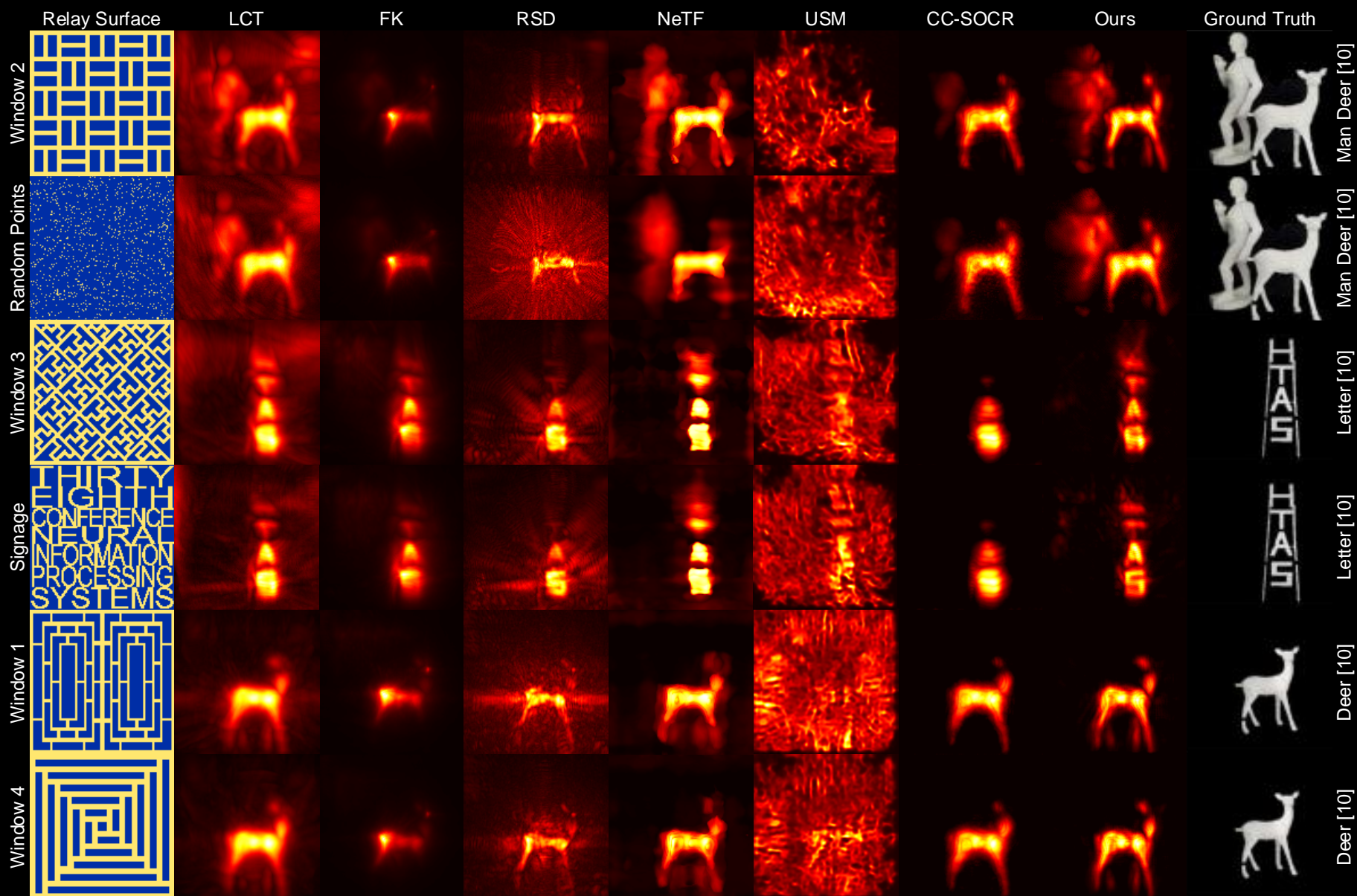


M_k

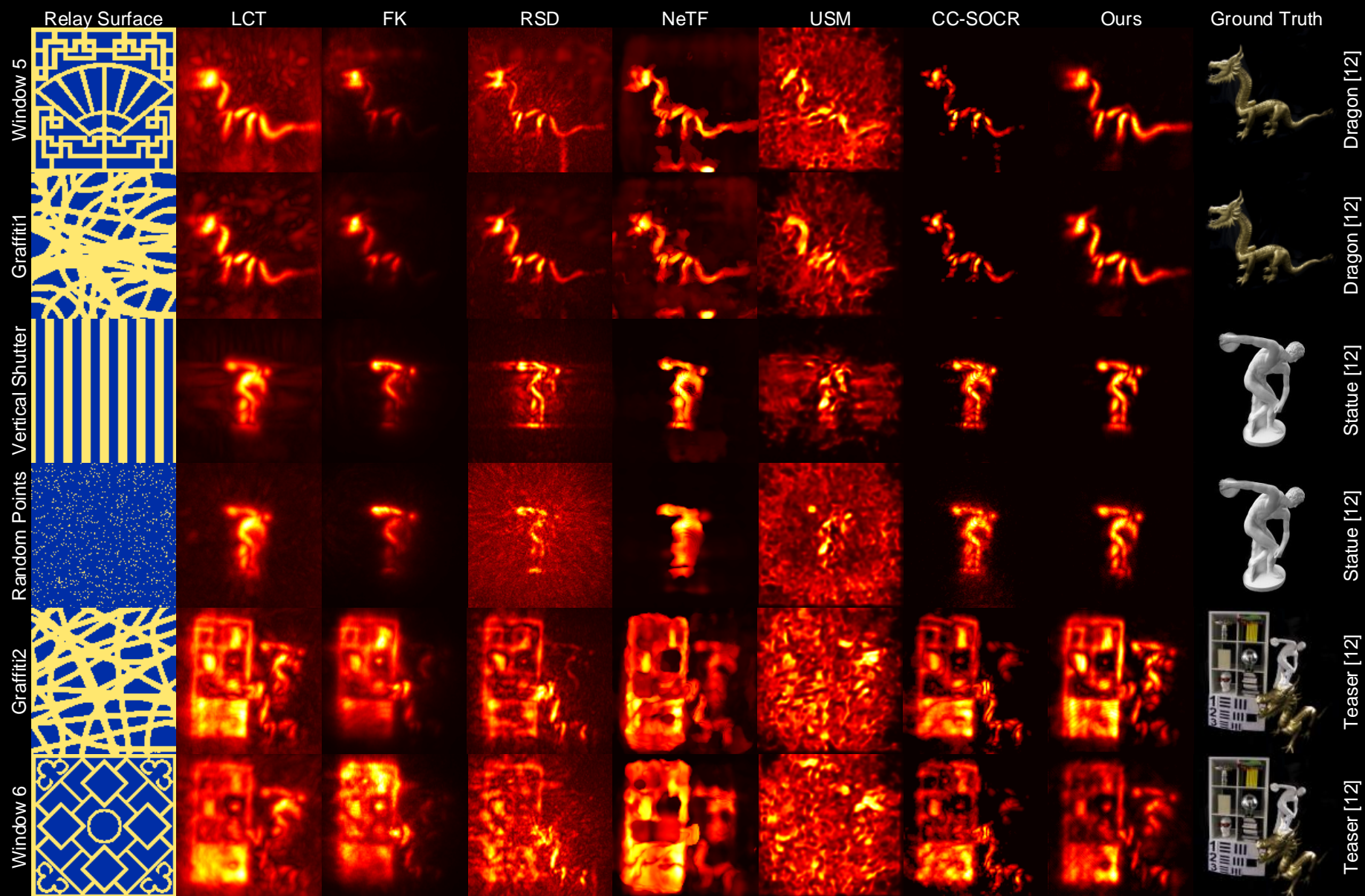
2D Relay Surface

3D Binary Mask

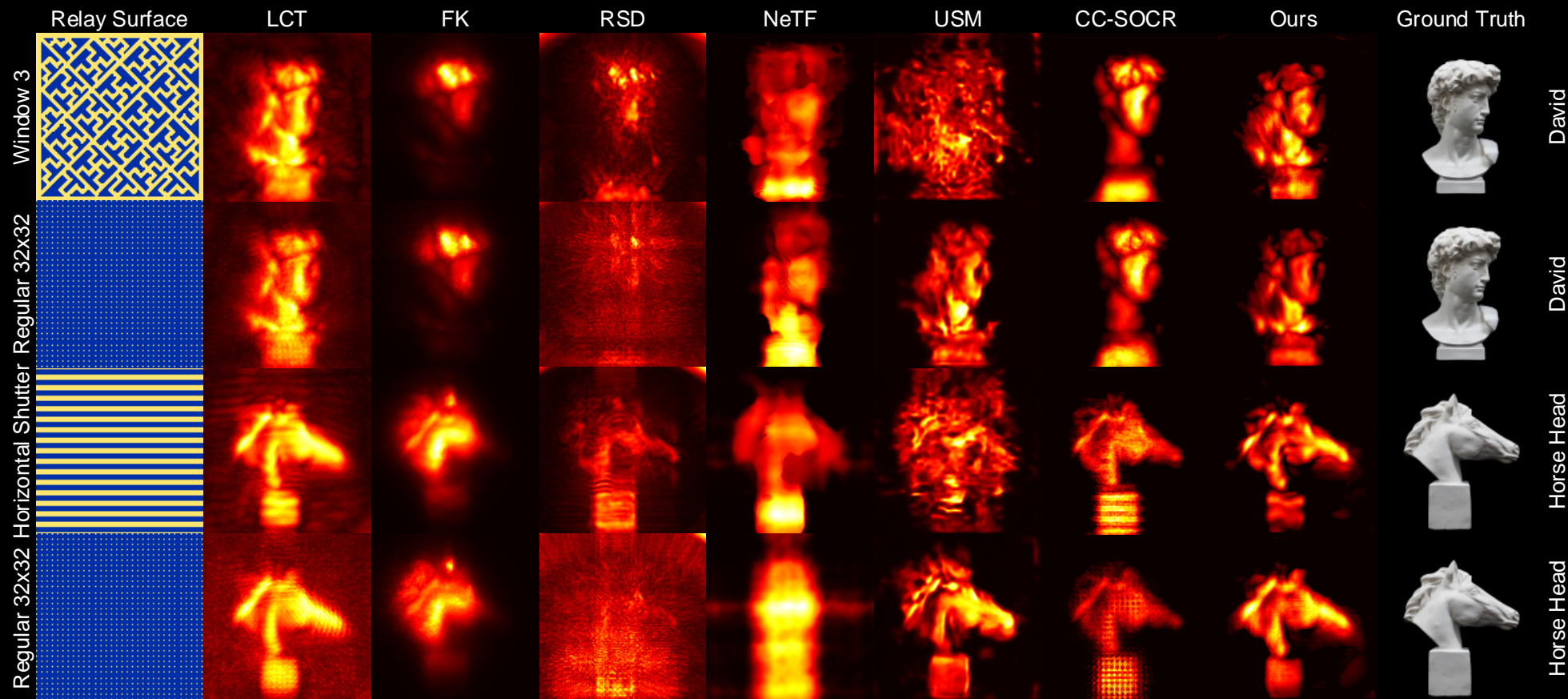
Results on public real-world dataset



Results on public real-world dataset



Results on self-captured real-world dataset

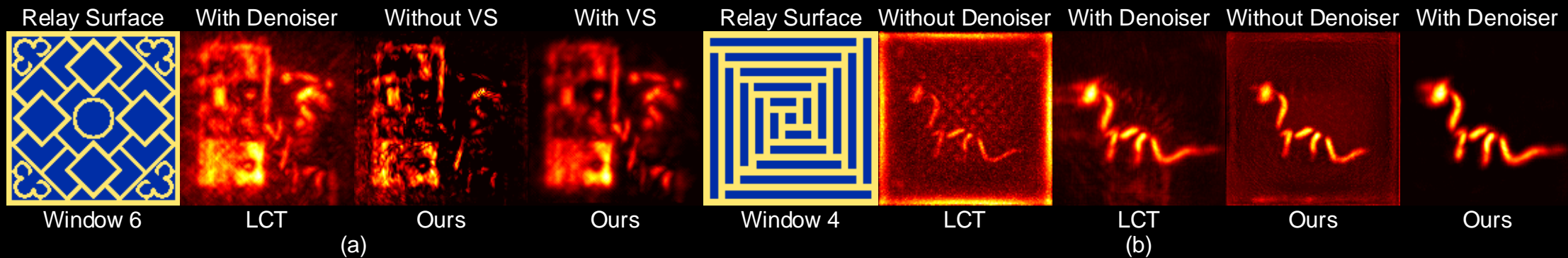


Inference Time

Method	LCT	FK	RSD	NeTF	USM	CC-SOCR	Ours
Runtime(CPU)	0.81 s	1.52 s	0.94 s	N/A	2.34 s	7.73 h	2.24 s
Runtime(GPU)	0.09 s	0.15 s	0.12 s	0.69 h	0.24 s	N/A	0.18 s

Ablation Study

Qualitative Results



Quantitative Results

SURE-based denoiser	Virtual Scanning Process	PSNR (dB)
×	√	18.69
√	×	19.63
√	√	20.52



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